

GSM4600

100V N & P Pair Enhancement Mode MOSFET

Product Description

These miniature surface mount MOSFETs utilize High Cell Density process. Low $R_{DS(ON)}$ assures minimal power loss and conserves energy, making this device ideal for use in power management circuitry.

Typical applications are PWM DC-DC converters, power management in portable and battery powered products such as computers, printers, battery charger, telecommunication power system, and telephones power system.

Features

N-Channel

- 100V, 9.8A, $R_{DS(ON)}=155m\Omega@V_{GS}=10V$
- 100V, 9.8A, $R_{DS(ON)}=175m\Omega@V_{GS}=4.5V$

P-Channel

- -100V, -9A, $R_{DS(ON)}=160m\Omega@V_{GS}=-10V$
- -100V, -9A, $R_{DS(ON)}=185m\Omega@V_{GS}=-4.5V$
- Fast switching speed
- SOP-8 package design

Applications

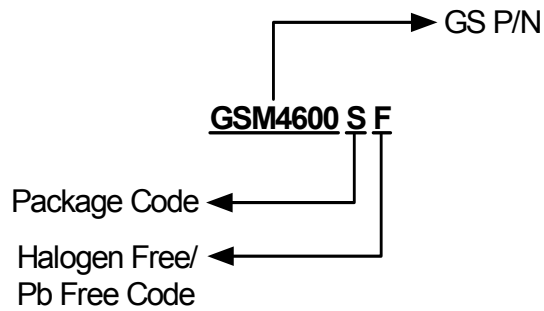
- Power Management in Note
- Portable Equipment
- Battery Powered System
- Load Switch
- LCD Display inverter

Packages & Pin Assignments

GSM4600SF(SOP-8)

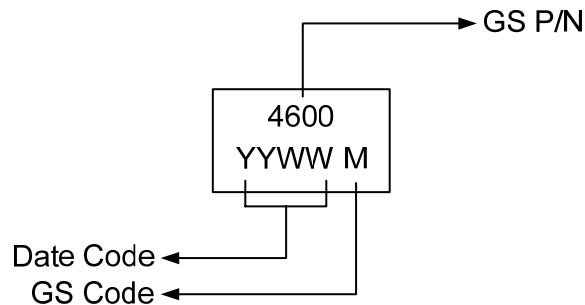
Pin	Description	Pin	Description
1	Source1	5	Drain2
2	Gate1	6	Drain2
3	Source2	7	Drain1
4	Gate2	8	Drain1

Ordering Information



Part Number	Package	Quantity Reel
GSM4600SF	SOP-8	4000 PCS

Marking Information



Absolute Maximum Ratings (N-Channel)

(T_A=25°C unless otherwise noted)

Symbol	Parameter	Typical	Unit
V _{DS}	Drain-Source Voltage	100	V
V _{GS}	Gate-Source Voltage	±20	V
I _D	Continuous Drain Current (*1)	T _A =25°C	9.8
		T _A =70°C	7
I _{DM}	Pulsed Drain Current (*2)	37	A
P _D	Power Dissipation (*1)	T _A =25°C	2.5
		T _A =70°C	1.6
T _J	Operating Junction Temperature Range	-55 to 150	°C
T _{STG}	Storage Temperature Range	-55 to 150	°C
T _L	Lead Temperature(1/16" from case for 10sec)	275	°C
R _{θJA}	Thermal Resistance-Junction to Ambient	50	°C/ W
R _{θJC}	Thermal Resistance-Junction to Case	30	°C/ W

Electrical Characteristics (N-Channel)

(T_C=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Unit		
Static								
V _{(BR)DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =250uA	100			V		
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _D =250uA	2	3	4	V		
I _{GSS}	Gate Leakage Current	V _{DS} =0V, V _{GS} =±20V			±250	nA		
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =80V, V _{GS} =0V			1	uA		
I _{D(on)}	On-State Drain Current (*3)	V _{DS} ≥ 5V, V _{GS} =10V	20			A		
R _{DS(on)}	Drain-Source On-Resistance (*3)	V _{GS} =10V, I _D =5.5A		125	155	mΩ		
		V _{GS} =4.5V, I _D =4A		140	175			
g _{FS}	Forward Transconductance (*3)	V _{DS} =50V, I _D =5.5A		2		S		
I _S	Continuous Current				9.6	A		
I _{SM}	Pulsed Current (*5)				37	A		
V _{SD}	Diode Forward Voltage (*3)	I _F =I _S , V _{GS} =0V			1.4	V		
Dynamic								
C _{iss}	Input Capacitance	V _{DS} =25V, V _{GS} =0V, f=1MHz		560		pF		
C _{oss}	Output Capacitance			81				
C _{rss}	Reverse Transfer Capacitance			10				
Q _g	Total Gate Charge (*4)	V _{DS} =0.5V _{(BR)DSS} , V _{GS} =10V, I _D =9.6A		22		nC		
Q _{gs}	Gate-Source Charge (*4)			5.2				
Q _{gd}	Gate-Drain Charge (*4)			7				
t _{d(on)}	Turn-On Time (*4)	V _{DD} =10V, I _D =1A, V _{GS} =10V, R _G =6Ω		2.2	4.4	ns		
T _r				7.5	15			
t _{d(off)}	Turn-Off Time (*4)			11.8	21.3			
T _f				3.7	7.4			
R _g	Gate Resistance		V _{GS} =V _{DS} =0V, f=1MHz		1.7		3	Ω

Absolute Maximum Ratings (P-Channel)

(T_A=25°C unless otherwise noted)

Symbol	Parameter	Typical	Unit
V _{DS}	Drain-Source Voltage	-100	V
V _{GS}	Gate-Source Voltage	±20	V
I _D	Continuous Drain Current (*1)	T _A =25°C	-9
		T _A =70°C	-6
I _{DM}	Pulsed Drain Current (*2)	-37	A
P _D	Power Dissipation (*1)	T _A =25°C	2.5
		T _A =70°C	1.6
T _J	Operating Junction Temperature Range	-55 to 150	°C
T _{STG}	Storage Temperature Range	-55 to 150	°C
T _L	Lead Temperature(1/16" from case for 10sec)	275	°C
R _{θJA}	Thermal Resistance-Junction to Ambient	50	°C/ W
R _{θJC}	Thermal Resistance-Junction to Case	30	°C/ W

Electrical Characteristics (P-Channel)

($T_C=25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Static						
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	$V_{GS}=0V, I_D=-250\mu A$	-100			V
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=-250\mu A$	-2	-3	-4	
I_{GSS}	Gate Leakage Current	$V_{DS}=0V, V_{GS}=\pm 20V$			± 250	nA
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS}=-80V, V_{GS}=0V$			-1	μA
$I_{D(on)}$	On-State Drain Current (*3)	$V_{DS}\leq -5V, V_{GS}=-10V$	-20			A
$R_{DS(on)}$	Drain-Source On-Resistance (*3)	$V_{GS}=-10V, I_D=-5.5A$		130	160	m Ω
		$V_{GS}=-4.5V, I_D=-4A$		145	185	
g_{FS}	Forward Transconductance (*3)	$V_{DS}=-50V, I_D=-5.5A$		1.6		S
I_S	Continuous Current				-9.6	A
I_{SM}	Pulsed Current (*5)				-37	A
V_{SD}	Diode Forward Voltage (*3)	$I_F=I_S, V_{GS}=0V$			-1.4	V
Dynamic						
C_{iss}	Input Capacitance	$V_{DS}=-25V,$ $V_{GS}=0V, f=1\text{MHz}$		1200		pF
C_{oss}	Output Capacitance			100		
C_{rss}	Reverse Transfer Capacitance			65		
Q_g	Total Gate Charge (*4)	$V_{DS}=-0.5V_{(BR)DSS},$ $V_{GS}=-10V, I_D=-5.5A$		43		nC
Q_{gs}	Gate-Source Charge (*4)			8		
Q_{gd}	Gate-Drain Charge (*4)			16		
$t_{d(on)}$	Turn-On Time (*4)	$V_{DD}=-10V,$ $I_D=-1A, V_{GS}=-10V,$ $R_G=6\Omega$		6.7	13.4	ns
T_r				9.7	19.4	
$t_{d(off)}$	Turn-Off Time (*4)			19.8	35.6	
T_f				12.3	22.2	
R_g	Gate Resistance		$V_{GS}=V_{DS}=0V, f=1\text{MHz}$		3	

Note 1: Pulse width limited by maximum junction temperature.

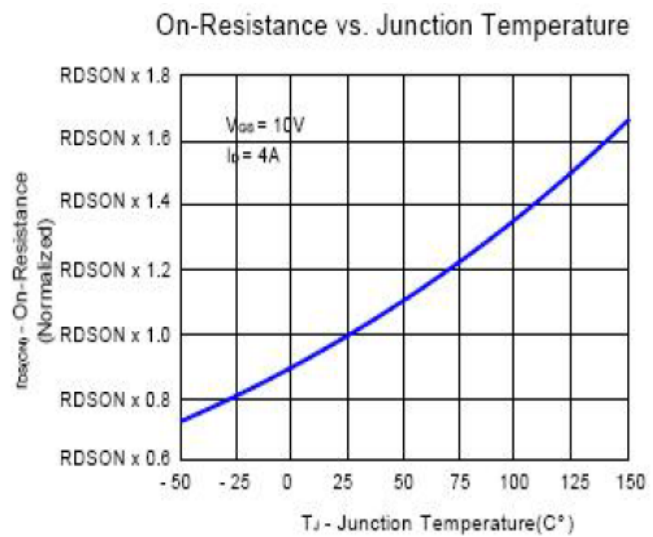
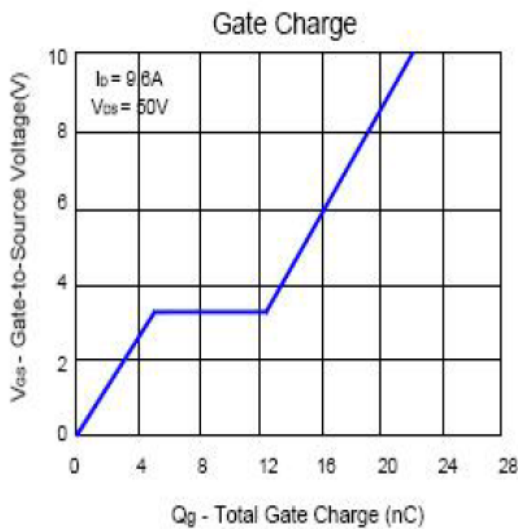
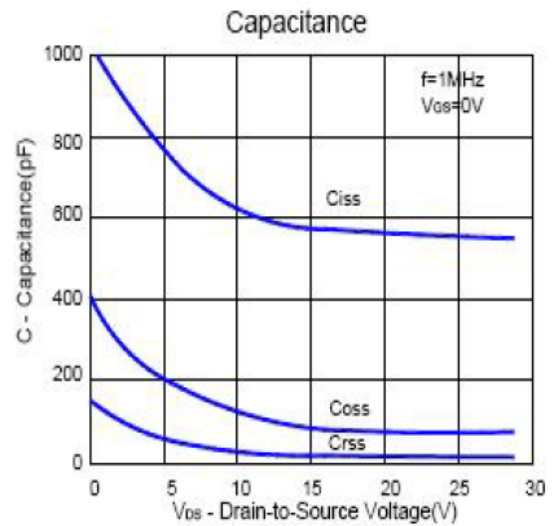
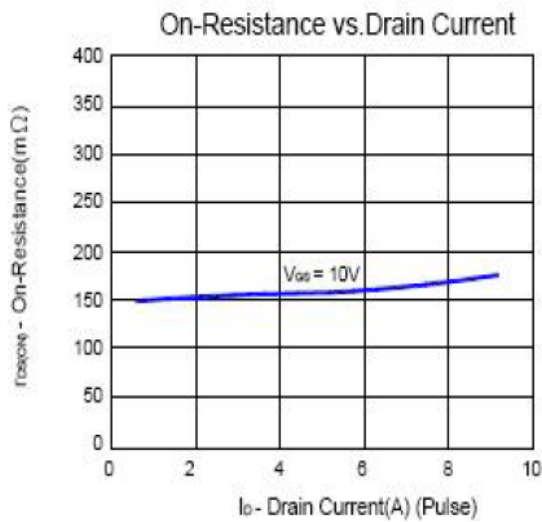
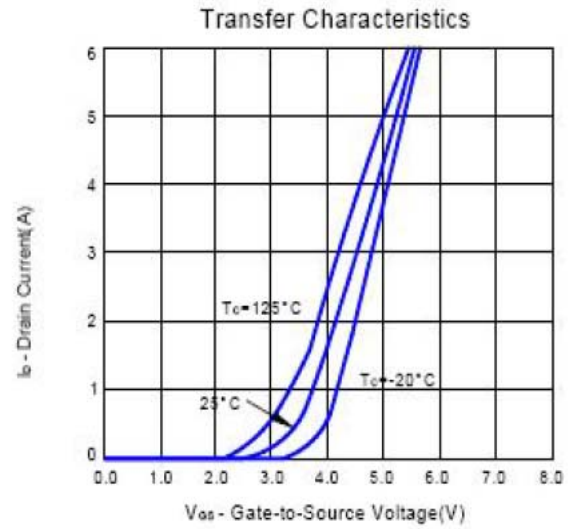
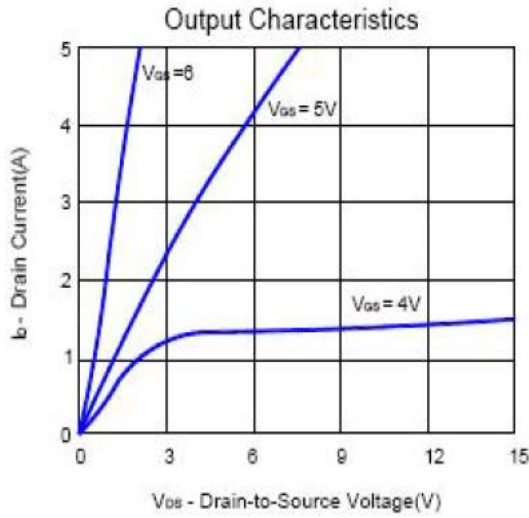
Note 2: Duty cycle $\leq 1\%$.

Note 3: Pulse test: $PW \leq 300\mu\text{sec}$, duty cycle $\leq 2\%$.

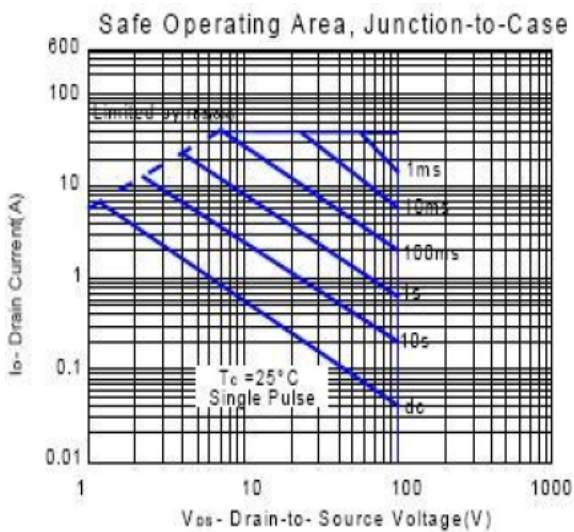
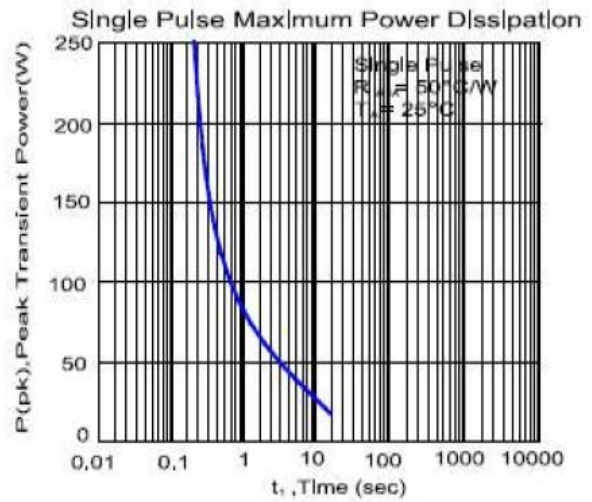
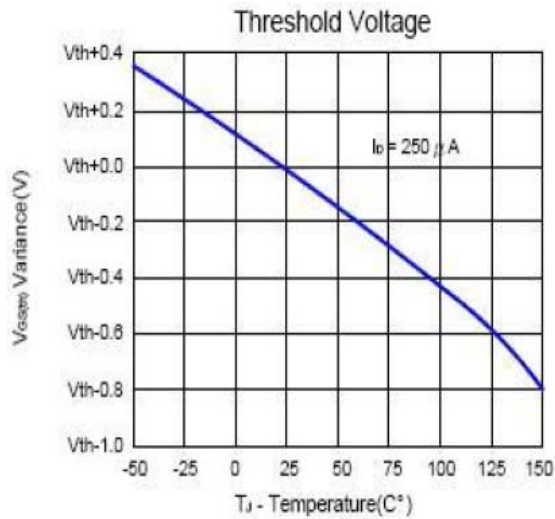
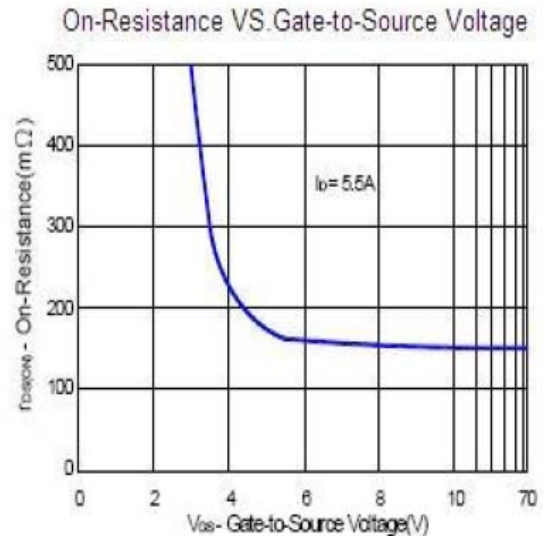
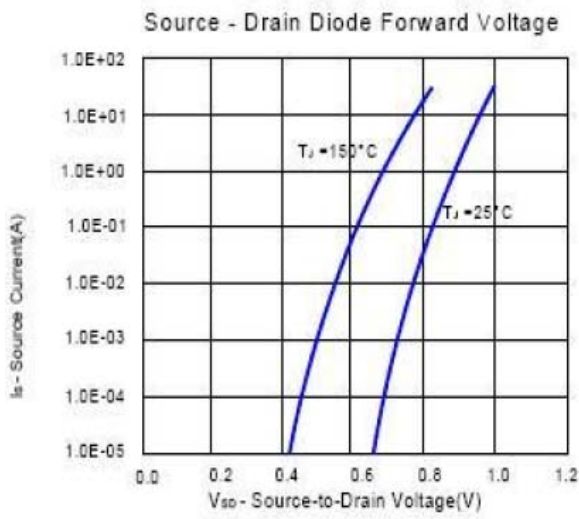
Note 4: Independent of operating temperature.

Note 5: Pulse width Limited by maximum junction temperature.

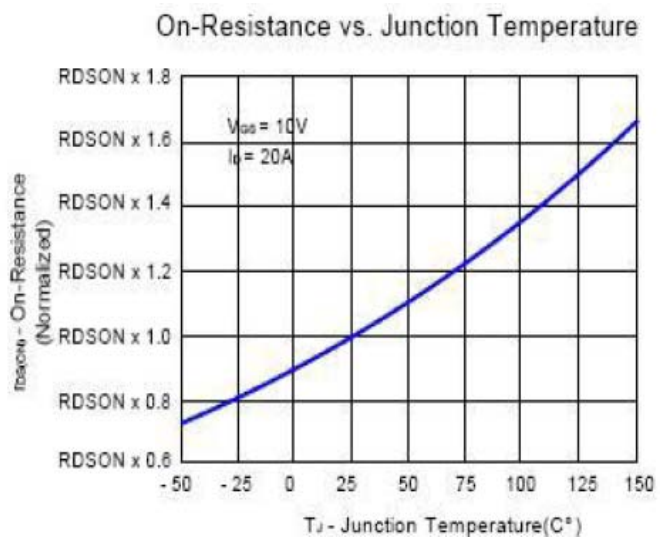
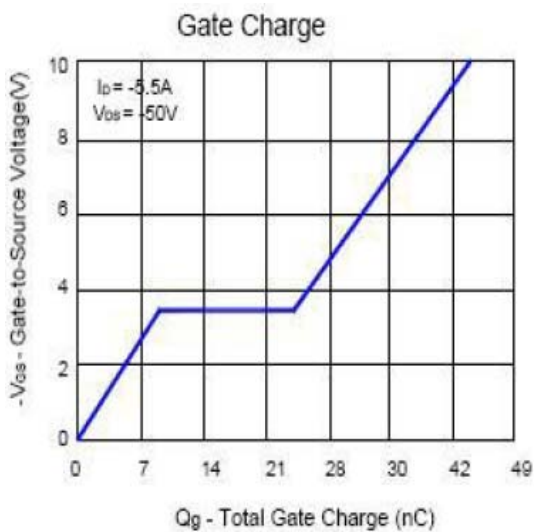
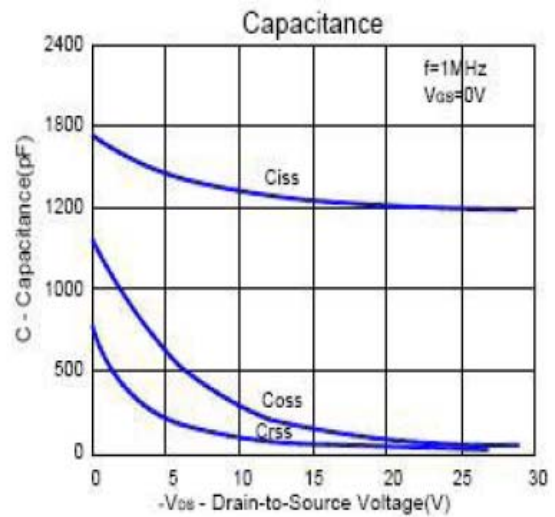
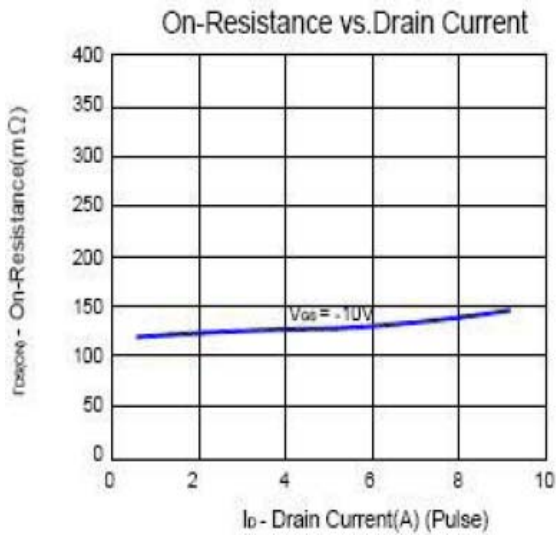
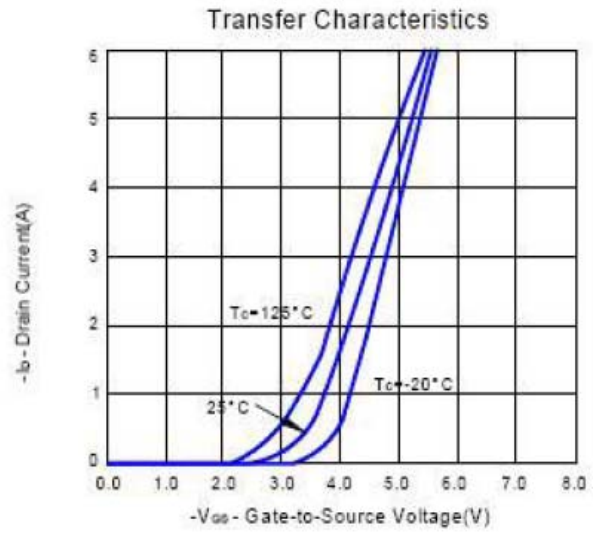
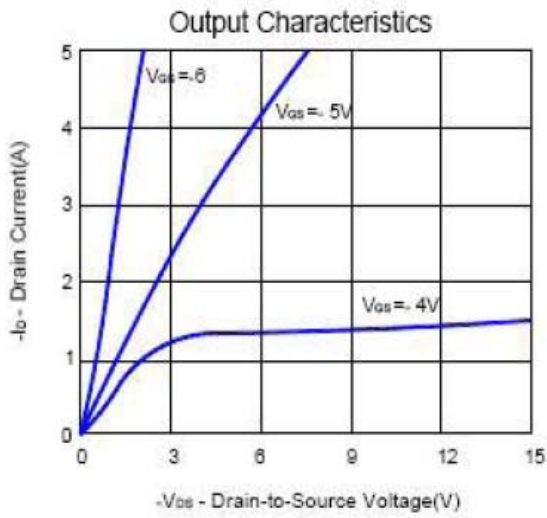
Typical Performance Characteristics (N-Channel)



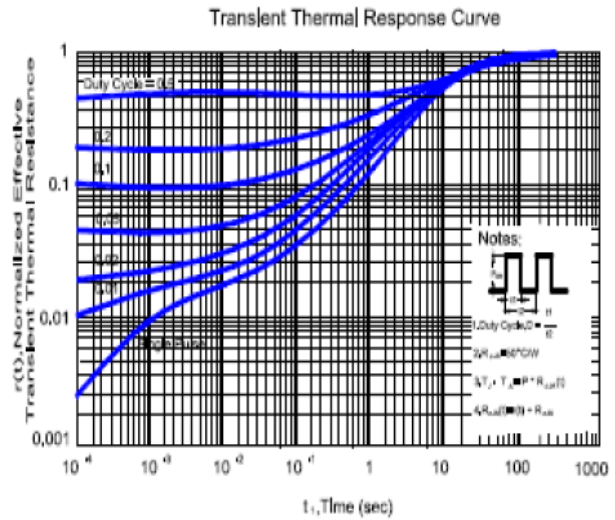
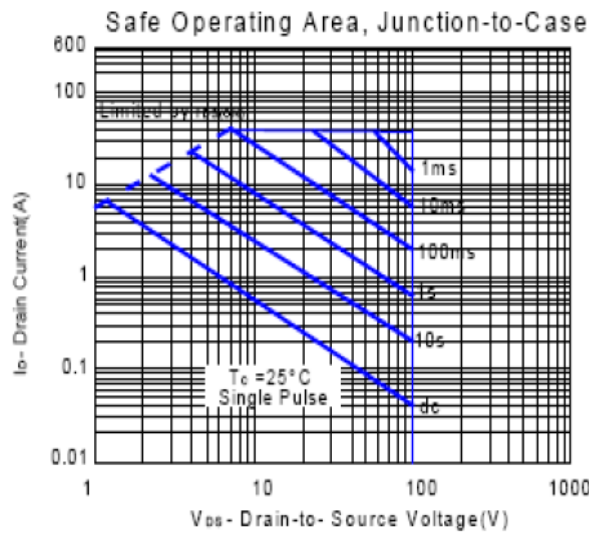
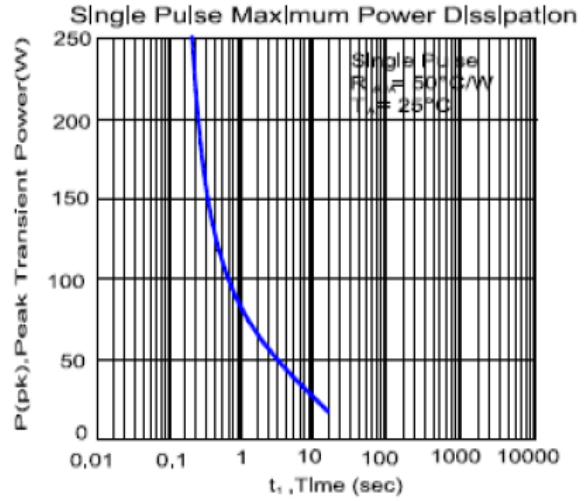
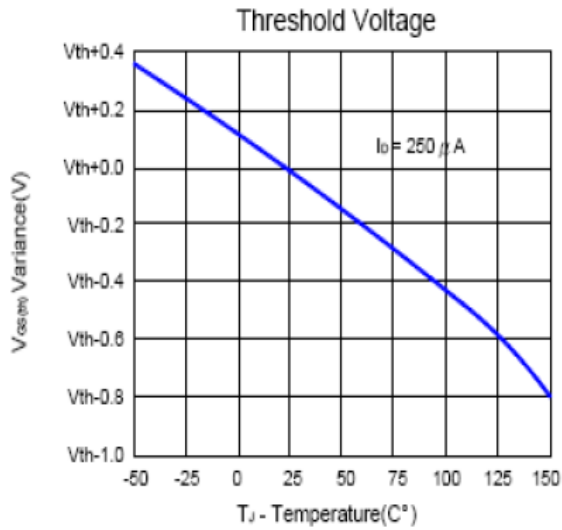
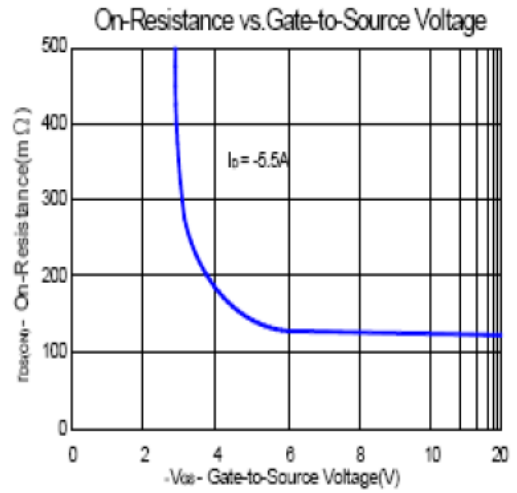
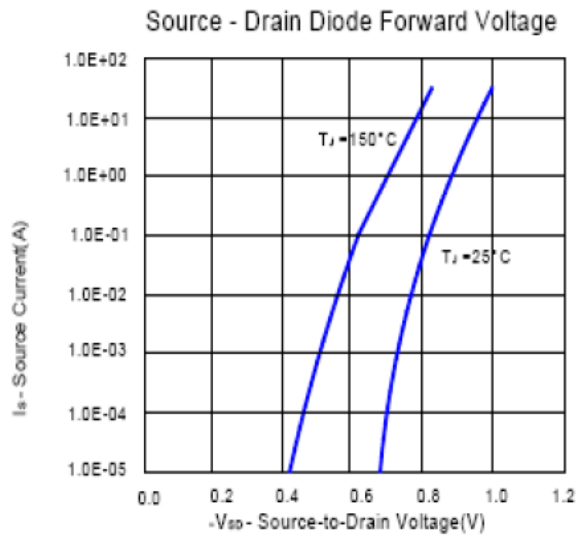
Typical Performance Characteristics (N-Channel)



Typical Performance Characteristics (P-Channel)

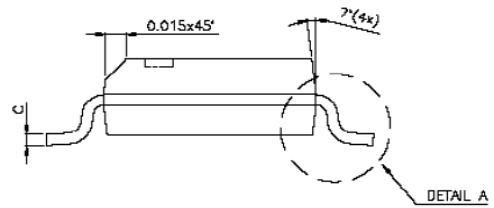
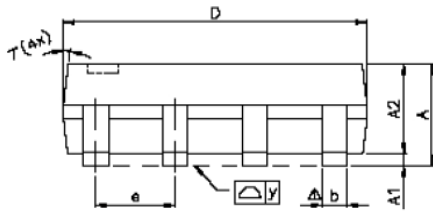
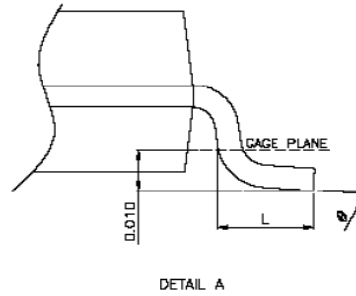
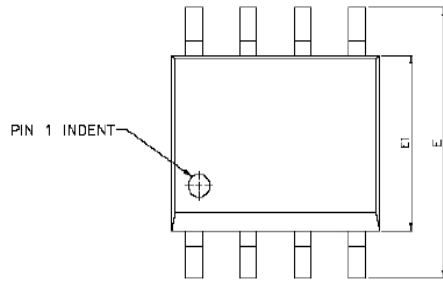


Typical Performance Characteristics (P-Channel)



Package Dimension

SOP-8










Dimensions						
SYMBOL	Millimeters			Inches		
	MIN	NOM	MAX	MIN	NOM	MAX
A	1.47	1.60	1.73	0.058	0.063	0.068
A1	0.10	-	0.25	0.004	-	0.010
A2	-	1.45	-	-	0.057	-
b	0.33	0.41	0.51	0.013	0.016	0.020
C	0.19	0.20	0.25	0.0075	0.008	0.0098
D	4.80	4.85	4.95	0.189	0.191	0.195
E	5.80	6.00	6.20	0.228	0.236	0.244
E1	3.80	3.90	4.00	0.150	0.154	0.157
e	-	1.27	-	-	0.050	-
L	0.38	0.71	1.27	0.015	0.028	0.050
Δy	-	-	0.076	-	-	0.003
θ	0°	-	8°	0°	-	8°



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